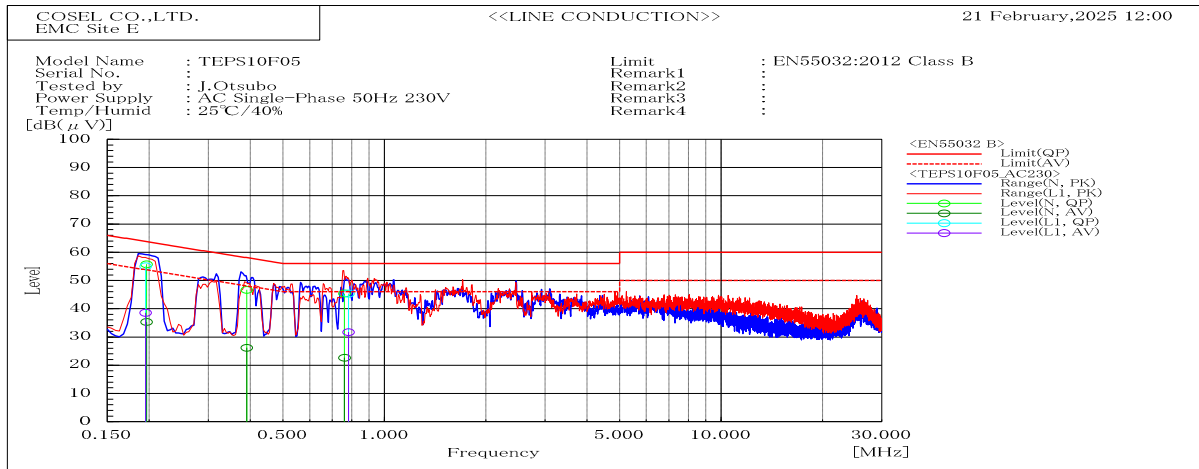
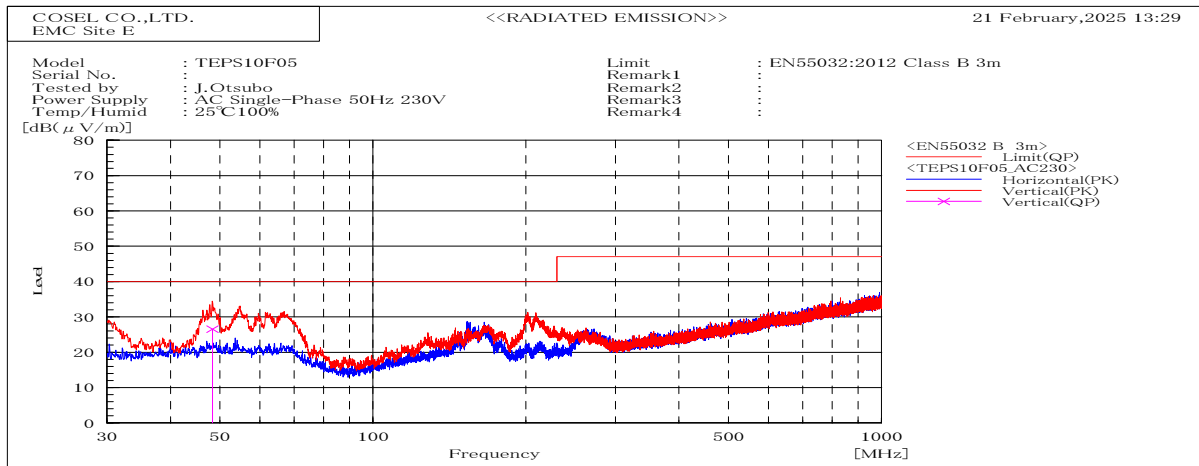


DATA SHEET

Model		TEPS10F05	Date	24-Mar-25
Test		EMI Line conduction & Radiated emission	Temp.	25 degreeC
			Humid.	40 %RH
			Tested by	T.Sakuma



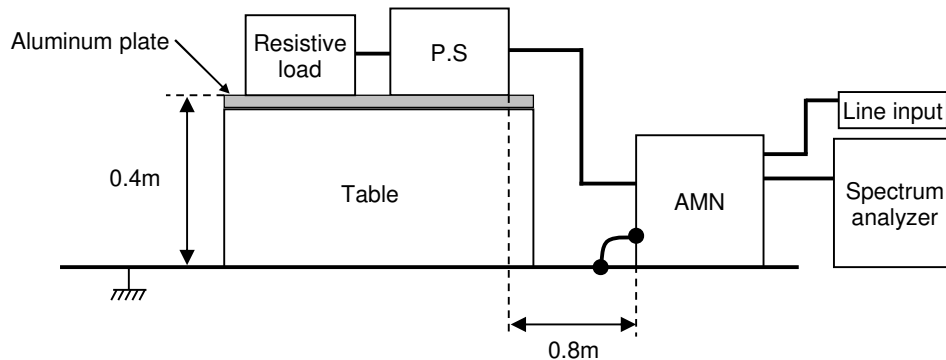
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.196	N	55.7	35.3	63.8	53.8	8.1	18.5	Pass	
0.39	N	46.7	26.2	58.1	48.1	11.4	21.9	Pass	
0.761	N	45.4	22.6	56	46	10.6	23.4	Pass	
0.195	L1	55	38.6	63.8	53.8	8.8	15.2	Pass	
0.783	L1	45.4	31.7	56	46	10.6	14.3	Pass	



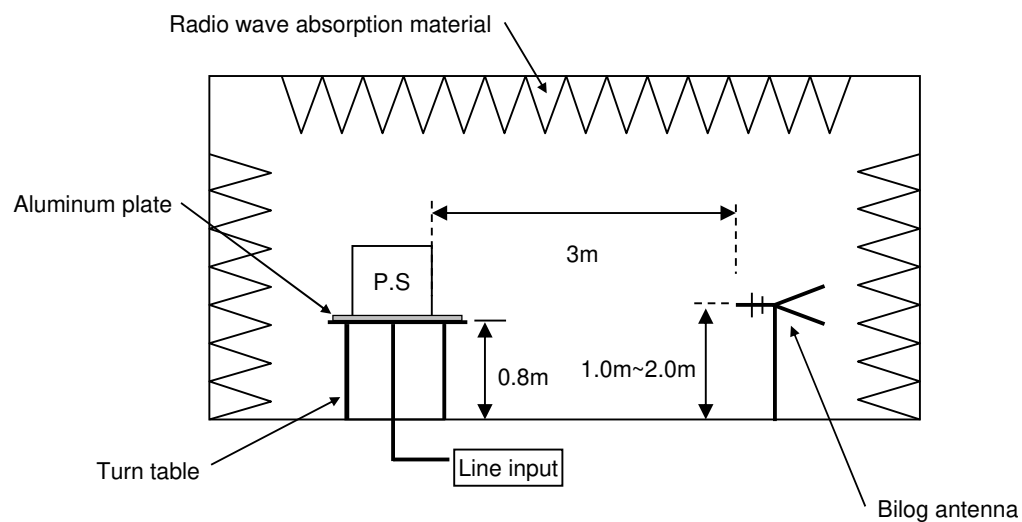
Frequency MHz	Polarization	Stability	Level dB(μV/m)		Limit dB(μV/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV						
48.396	V	Stable	26.5	40	40	13.5	Pass	100	65.4	

DATA SHEET		Date	24-Mar-25
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma

1. Line conduction



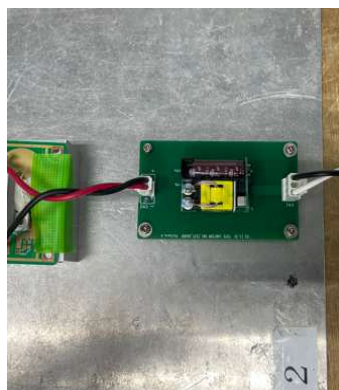
2. Radiated emission



Conditions

Test : EMI
Model Name : TEPS10F05

1.LINE CONDUCTION



2.RADIATED EMISSION

